

FCC - TEST REPORT

Report Number	:	60.790.23.030.01R02	Date of Issue	: 31 August, 2023				
Model	:	PadLock						
Product Type	:	SmartLock						
Applicant	:	Mobile Technologies Inc.						
Address	:	1050 NE 67th Ave, Hillsbo	oro, Oregon, 971	24, United States				
Production Facility (1)	:	IBE Electronics Co., Ltd.						
Address	:	IBE Industry Mansion, Tai Town, Bao'an District, Sho	•	stry Estate, Shiyan				
Production Facility (2)	:	VIETNAM IBE LASER TE	VIETNAM IBE LASER TECHNOLOGY CO LTD.					
Address	:	Lot CN-34 and lot CN-39, Thuan Thanh II Industrial Park, An Binh & Mao Dien Commune, Thuan Thanh District, Bac Ninh Province, Vietnam.						
Test Result	:	n Positive of	Negative					
Total pages including Appendices	:	21						

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2 Description of Equipment Under Test

Description of the Equipment Under Test

Product: SmartLock

Model no.: PadLock

FCC ID: 2AA2X-15000345

Rating: 3.0 VDC (2 x 1.5 VDC "AAA" size battery)

Frequency: 125 kHz

Antenna gain: 0 dBi (Coil Antenna)

Modulation: AM

Auxiliary Equipment Used during Test:

DESCRIPTION	MANUFACTURER	MODEL NO.	REMARK
MTI Connect HUB	MTI		System Monitoring
User Tags	MTI		System Monitoring

Auxiliary Software Used during Test:

DESCRIPTION	SOFTWARE NAME	VERSION	REMARK
/	/	/	/



3 Summary of Test Standards

Test Standards

FCC Part 15 Subpart C 10-1-21 Edition
Federal Communications Commission, PART 15 — Radio Frequency Devices,
Subpart C — Unintentional Radiators

All the tests were performed using the procedures from ANSI C63.4(2014) and ANSI C63.10 (2013).



4 Details about the Test Laboratory

Site 1

Company name: TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch

Building 12&13 Zhiheng Wisdomland Business Park, Nantou Checkpoint Road 2,

Nantou Checkpoint Road 2, Shenzhen 518052, P.R.China FCC Registration Number: 514049 ISED test site number: 10320A

Emission Tests			
Test Item	Test Site		
FCC Part 15 Subpart C	·		
FCC Title 47 Part 15.205, 15.209 Spurious Radiated Emission	Site 1		
FCC Title 47 Part 15.207 Conduct Emission	N/A		
FCC Title 47 Part 15.215 20dB & 99%Bandwidth	Site 1		



4.1 Test Equipment Site List

Radiated Emission Test

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
EMI Test Receiver	Rohde & Schwarz	ESR 26	101269	2024-5-20
Loop Antenna	Rohde & Schwarz	HFH2-Z2	100398	2024-8-7
Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9162	284	2024-3-5
Wave Guide Antenna	ETS	3117	00218954	2024-4-26
Pre-amplifier	Rohde & Schwarz	SCU 18F	100745	2024-5-19
Pre-amplifier	Rohde & Schwarz	SCU 18F	100746	2024-5-19
Sideband Horn Antenna	Q-PAR	QWH-SL-18- 40-K-SG	12827	2024-7-11
Pre-amplifier	Rohde & Schwarz	SCU 40A	100432	2024-5-19
Attenuator	Mini-circuits	UNAT-6+	15542	2024-5-19
3m Semi-anechoic chamber	TDK	SAC-3 #2		2024-5-28
Test software	Rohde & Schwarz	EMC32	Version10.35.02	N/A

Conducted Emission Test

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
EMI Test Receiver	Rohde & Schwarz	ESR 3	101782	2024-5-20
LISN	Rohde & Schwarz	ENV4200	100249	2024-5-20
LISN	Rohde & Schwarz	ENV432	101318	2024-5-20
LISN	Rohde & Schwarz	ENV216	100326	2024-5-20
LISN	Rohde & Schwarz	ENV216	102472	2024-5-20
ISN	Rohde & Schwarz	ENY81	100177	2024-5-20
ISN	Rohde & Schwarz	ENY81-CA6	101664	2024-5-27
High Voltage Probe	Schwarzbeck	TK9420(VT9420)	9420-584	2024-5-31
RF Current Probe	Rohde & Schwarz	EZ-17	100816	2024-5-19
Attenuator	Shanghai Huaxiang	TS2-26-3	080928189	N/A
Test software	Rohde & Schwarz	EMC32	Version9.15.00	2025-10-15
Shielding Room	TDK	CSR #1		2024-5-20

20dB & 99% Bandwidth, Peak Output Power, Spurious Emissions at Antenna Terminals, 100kHz Bandwidth of band edges, Power Spectral Density

DESCRIPTION MANUFACTURER MODEL NO. SERIAL NO. CAL. DUE DATE Signal Analyzer Rohde & Schwarz FSV40 101030 2024-5-19 OSP120/OSP-RF Switch Module Rohde & Schwarz 101226/100851 2024-5-20 B157



4.2 Measurement System Uncertainty

Measurement System Uncertainty Emissions

System Measurement Uncertainty			
Items	Extended Uncertainty		
Uncertainty for Radiated Emission in 3m chamber 9kHz-30MHz	4.76dB		
Uncertainty for Radiated Emission in 3m chamber 30MHz-1000MHz	Horizontal: 5.12dB; Vertical: 5.10dB;		
Uncertainty for Radiated Emission in 3m chamber 1000MHz-25000MHz	Horizontal: 5.01dB; Vertical: 5.00dB;		
Uncertainty for Conducted Emission at AC Power Line 150kHz-30MHz	3.21dB		
Uncertainty for conducted power test	1.16dB		
Uncertainty for frequency test	0.6×10 ⁻⁷		

Measurement Uncertainty Decision Rule

Determination of conformity with the specification limits is based on the decision rule according to IEC Guide 115: 2007, clause 4.4.3 and 4.5.1.



5 Summary of Test Results

Emission Tests				
FCC Part 15 Subpart C				
Test Condition	Pages	Te	st Res	ult
		Pas	Fail	N/A
		S		
FCC Title 47 Part 15.205, 15.209 Spurious Radiated Emission	12-14	\square		
FCC Title 47 Part 15.207 Conduct Emission (1)				\boxtimes
FCC Title 47 Part 15.215 20dB & 99% Bandwidth	15			

Remark:

(1) Test not applicable for the Battery Operate Device



6 General Remarks

Remarks

All tests were performed on model: PadLock.

This submittal(s) (test report) is intended for **FCC ID: 2AA2X-15000345**, complies with Section 15.205, 15.209, 15.215 of the FCC Part 15, Subpart C rules for the DCD grant.

The TX and RX frequency range is 125kHz.

SUMMARY:

- All tests according to the regulations cited on page 8 were
 - n Performed
 - o Not Performed
- The Equipment Under Test
 - n Fulfills the general approval requirements.
 - O Does not fulfill the general approval requirements.

Sample Received Date: 12 August 2023

Testing Start Date: 14 August 2023

Testing End Date: 30 August 2023

- TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch -

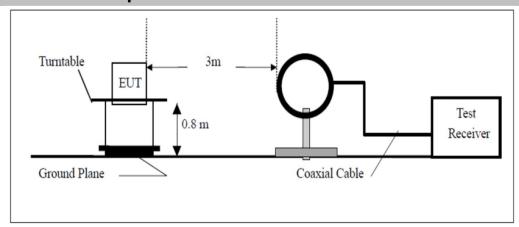
Reviewed by: Prepared by: Tested by:

Eric LI Section Manager Kevin DU EMC Project Engineer Louise LIU EMC Test Engineer

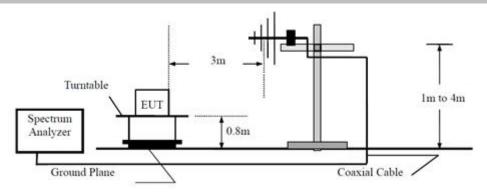


7 Test Setups

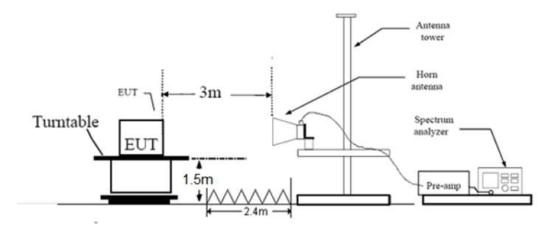
7.1 Radiated test setups 9kHz-30MHz



7.2 Radiated test setups 30MHz-1GHz

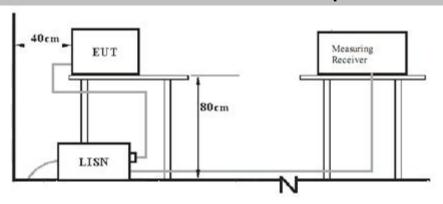


7.3 Radiated test setups Above 1GHz

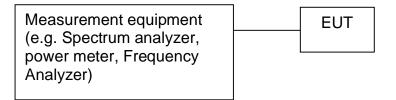




7.4 AC Power Line Conducted Emission test setups



7.5 Conducted RF test setups





8 Emission Test Results

8.1 Spurious Radiated Emission

EUT: PadLock

Op Condition: Operated, TX Mode Test Specification: FCC15.205, 15.209

Comment: 3.0 VDC

Remark: 9kHz to 30MHz

Test Result	
□ Passed	
Not Passed	

Frequency	Result	Limit	Margin	Detector	RSE. or Fund.
MHz	dBµV/m	dBµV/m	dB	PK/QP/AV	
0.125000	45.76	105.60	59.84	Peak	Fundamental
0.023946	62.16	120.01	57.84	Peak	Spurious emission
0.071980	53.87	110.45	56.58	Peak	Spurious emission
0.120014	50.70	106.01	55.31	Peak	Spurious emission
0.124432	42.57	105.70	63.12	Peak	Spurious emission
0.135994	50.16	104.93	54.77	Peak	Spurious emission
2.408650	40.51	69.50	28.99	Peak	Spurious emission

Remark:

- 1. According to C63.10, if the peak measured value complies with the quasi-peak limit, it is unnecessary to perform a quasi-peak measurement, so quasi-peak emission value did not show in data table if the peak value complies with quasi-peak limit.
- Consequence Level=Reading Level + Correction Factor
 Above 1GHz: Corrector factor = Antenna Factor + Cable Loss- Amplifier Gain
 Below 1GHz: Corrector factor = Antenna Factor + Cable Loss
 (The Reading Level is recorded by software which is not shown in the sheet)
- 3. The testing was performed at 3m distance, the limit has been transferred form 300m/30m to 3m.



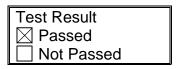
Spurious Radiated Emission

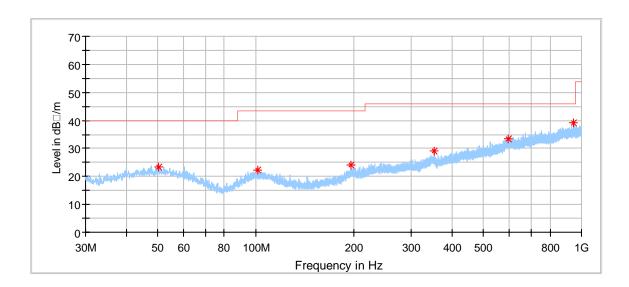
EUT: PadLock

Op Condition: Operated, TX Mode Test Specification: FCC15.205, 15.209

Comment: 3.0 VDC

Remark: 30MHz to 1GHz, Antenna: Horizontal





Critical Freqs

_		
MaxPeak	Limit	Margin
(dBµV/m)	(dBµV/m)	(dB)
23.27	40.00	16.73
22.25	43.50	21.25
24.00	43.50	19.50
29.13	46.00	16.87
33.24	46.00	12.76
38.95	46.00	7.05
	(dBμV/m) 23.27 22.25 24.00 29.13 33.24	(dBμV/m) (dBμV/m) 23.27 40.00 22.25 43.50 24.00 43.50 29.13 46.00 33.24 46.00



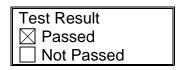
Spurious Radiated Emission

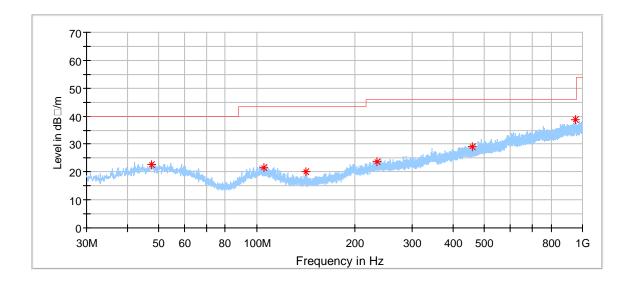
EUT: PadLock

Op Condition: Operated, TX Mode Test Specification: FCC15.205, 15.209

Comment: 3.0 VDC

Remark: 30MHz to 1GHz, Antenna: Vertical





Critical_Freqs

Frequency	MaxPeak	Limit	Margin
(MHz)	(dBµV/m)	(dBµV/m)	(dB)
47.460000	22.63	40.00	17.37
104.851667	21.59	43.50	21.91
142.035000	20.24	43.50	23.26
233.915556	23.52	46.00	22.48
459.979444	29.14	46.00	16.86
950.476111	38.76	46.00	7.24



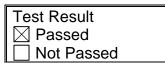
8.2 20dB Bandwidth

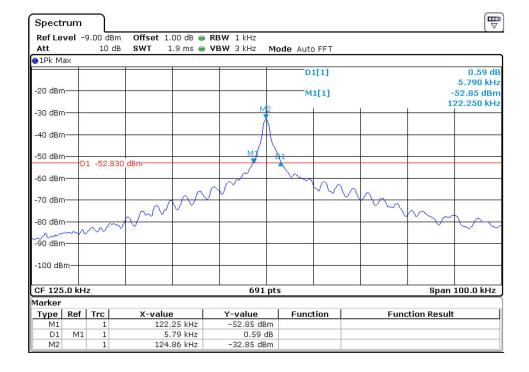
EUT: PadLock

Op Condition: Operated, TX Mode

Test Specification: FCC15.215, 20dB Bandwidth

Comment: 3.0 VDC





Bandwidth	Measured Value	
20dB bandwidth	5.79 kHz	



9 Test setup procedure

9.1 Field strength of emissions and Restricted bands

Test Method

- 1: The EUT was place on a turn table which is 1.5m above ground plane for above 1GHz and 0.8m above ground for below 1GHz at 3-meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- 2: The EUT was set 3 meters away from the interference receiving antenna, which was mounted on the top of a variable height antenna tower.
- 3: The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 4: For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- 5: Use the following spectrum analyzer settings According to C63.10:

For Above 1GHz

Span = wide enough to capture the peak level of the in-band emission and all spurious RBW = 1MHz, VBW≥3RBW, Sweep = auto, Detector function = peak and average, Trace = max hold.

For Below 1GHz

Use the following spectrum analyzer settings:

Span = wide enough to capture the peak level of the in-band emission and all spurious RBW = 120KHz, VBW≥3RBW, Sweep = auto, Detector function = QP,

Trace = max hold.



Field strength of emissions and Restricted bands

Limits

According to §15.209 (a), the field strength of emissions from intentional radiators shall not exceed the field strength levels specified in the following table:

Fundamental frequency (MHz)	Field strength (microvolts/meter)	Field strength of harmonics (microvolts/meter)
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30.0	30	30
30-88	100	3
88-216	150	3
216-960	200	3
Above 960	500	3



9.2 Conducted Emission at AC Power line

Test Method

- 1. The EUT was placed on a table, which is 0.8m above ground plane
- 2. The power line of the EUT is connected to the AC mains through a Artificial Mains Network (A.M.N.).
- 3. Maximum procedure was performed to ensure EUT compliance
- 4. A EMI test receiver is used to test the emissions from both sides of AC line

Limit

Frequency	QP Limit	AV Limit
MHz	dΒμV	dΒμV
0.150-0.500	66-56*	56-46*
0.500-5	56	46
5-30	60	50

^{*}Decreasing linearly with logarithm of the frequency.



9.3 20dB Bandwidth

Test Method

- 1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- 2. Position the EUT without connection to spectrum analyser. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- 3. Measure the frequency difference of two frequencies that were attenuated 20dB from the reference level. Record the frequency difference as the emission bandwidth.

Limits:

According to 15.215 (c) Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in Subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated. The requirement to contain the designated bandwidth of the emission within the specified frequency band includes the effects from frequency sweeping, frequency hopping and other modulation techniques that may be employed as well as the frequency stability of the transmitter over expected variations in temperature and supply voltage. If a frequency stability is not specified in the regulations, it is recommended that the fundamental emission be kept within at least the central 80% of the permitted band in order to minimize the possibility of out-of-band operation.



10 Appendix A - General Product Information

Radiofrequency radiation exposure evaluation

This exposure evaluation is intended for FCC ID: 2AA2X-15000345

According to KDB 447498 D01v06 section 4.3.1, For frequencies below 100 MHz and test separation distances ≤ 50 mm, the Numeric threshold is determined as:

Step a)

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] \cdot [$\sqrt{f(GHz)}$] \leq 3.0 for 1-g SAR

Step b)

{[Power allowed at numeric threshold for 50mm in step a)] + [(test separation distance – 50mm) · (f(MHz)/150)]} mW

Step c) 1)

For test separation distances > 50mm and < 200mm, the power threshold at the corresponding test separation distance at 100MHz in step b) is multiplied by [1 + log(100/f(MHz))]

Step c) 2)

For test separation distances \leq 50mm, the power threshold determined by the equation in c) 1) for 50mm and 100MHz is multiplied by $\frac{1}{2}$.

>> The fundamental frequency of the EUT is 125kHz, the test separation distance is ≤ 50mm. (Manufacturer specified the separation distance is: 20mm)

Step a)

>> Numeric threshold, mW / 50mm * √0.1GHz ≤ 3.0 Numeric threshold ≤ 474.3mW

Step b)

>> Numeric threshold ≤ 474.3mW + (50mm-50mm) * 100MHz/150) Numeric threshold ≤ 474.3mW

Step c) 1) & c) 2)

- >> Numeric threshold ≤ 474.3mW * [1 + log 100/100MHz] * ½
 Numeric threshold ≤ 237.15mW
- >> The power (calculated power + tune up tolerance) of EUT at 125kHz is: 0.00001mW Which is smaller than the Numeric threshold.

Therefore, the device is exempt from stand-alone SAR test requirements.



Appendix A

Power calculation (According to C63.10 chapter 9.5)

	Value	Unit
Field Strength Measured (E)	45.76	dBµV/m
Measurement Distance (D)	3	m
Equivalent Isotropically Radiated Power (E.I.R.P in dBm)	-49.4	dBm
Equivalent Isotropically Radiated Power (E.I.R.P in mW)	0.00001	mW

Remark: EIRP = E + $20\log(D) - 104.7$

(EIRP is in dBm, E is in dBµV/m, D is in meters)

Reviewed by:

Prepared by:

Eric LI

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Kevin DU EMC Project Engineer